

**U74HCT165E**

Preliminary

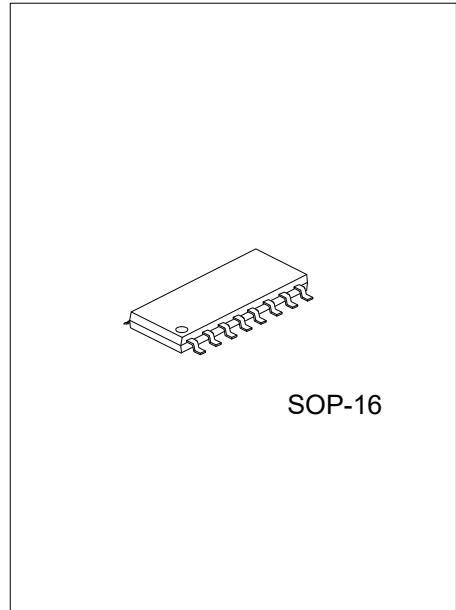
CMOS IC

8-BIT PARALLEL-LOAD SHIFT REGISTER**■ DESCRIPTION**

The **U74HCT165E** is an 8-bit parallel-load shift register that, when clocked, shifts the data toward a serial (Q_H) output. Parallel-in access to each stage is provided by eight individual direct data (A-H) inputs these are enabled by a low level at shift/load ($SH/\overline{LD}$) input. The **U74HCT165E** also features a clock-inhibit ($CLK\ INH$) function and a complementary serial ($\overline{Q}_H$) output.

Clocking is accomplished by a low-to-high transition of the clock (CLK) input while $SH/\overline{LD}$ is held high and $CLK\ INH$ is held low. The functions of CLK and $CLK\ INH$ are interchangeable. Since a low CLK and a low-to-high transition of $CLK\ INH$ also accomplish clocking, $CLK\ INH$ should be changed to the high level only while CLK is high. Parallel loading is inhibited when $SH/\overline{LD}$ is held high. While $SH/\overline{LD}$ is low, the parallel inputs to the register are enabled independently of the levels of the CLK , $CLK\ INH$, or serial (SER) inputs.

The inputs are compatible with TTL, NMOS and CMOS output voltage levels.



SOP-16

■ FEATURES

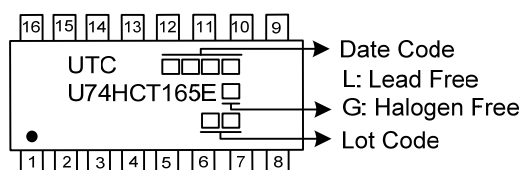
- * Complementary Outputs
- * Direct Overriding Load (Data) Inputs
- * Gated Clock Inputs
- * Parallel-to-Serial Data Conversion
- * Compatible with TTL, NMOS, CMOS output voltage levels

■ ORDERING INFORMATION

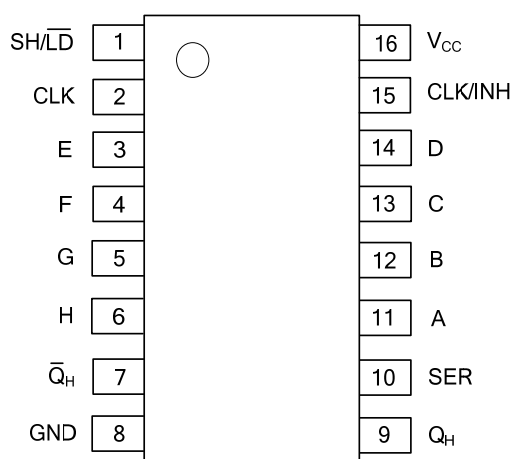
Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74HCT165EL-S16-R	U74HCT165EG-S16-R	SOP-16	Tape Reel

U74HCT165EG-S16-R	
(1) Packing Type	(1) R: Tape Reel
(2) Package Type	(2) S16: SOP-16
(3) Green Package	(3) G: Halogen Free and Lead Free, L: Lead Free

MARKING



PIN CONFIGURATION



FUNCTION TABLE

Operating Modes	Inputs					Qn Registers		Outputs	
	SH/LD	CLK/INH	CLK	SER	A to H	Q_A	Q_B to Q_G	Q_H	$\bar{Q}_H$
Parallel Load	L	X	X	X	L	L	L to L	L	H
	L	X	X	X	H	H	H to H	H	L
Serial Shift	H	L	↑	l	X	L	q_A to q_F	q_G	$\bar{q}_G$
	H	L	↑	h	X	H	q_A to q_F	q_G	$\bar{q}_G$
	H	↑	L	l	X	L	q_A to q_F	q_G	$\bar{q}_G$
	H	↑	L	h	X	H	q_A to q_F	q_G	$\bar{q}_G$
Hold "Do Nothing"	H	H	X	X	X	q_A	q_B to q_G	q_H	$\bar{q}_H$
	H	X	H	X	X	q_A	q_B to q_G	q_H	$\bar{q}_H$

Notes: H=HIGH Voltage Level;

h= HIGH Voltage Level one set-up time prior to the LOW-to-HIGH clock transition;

L=LOW Voltage Level;

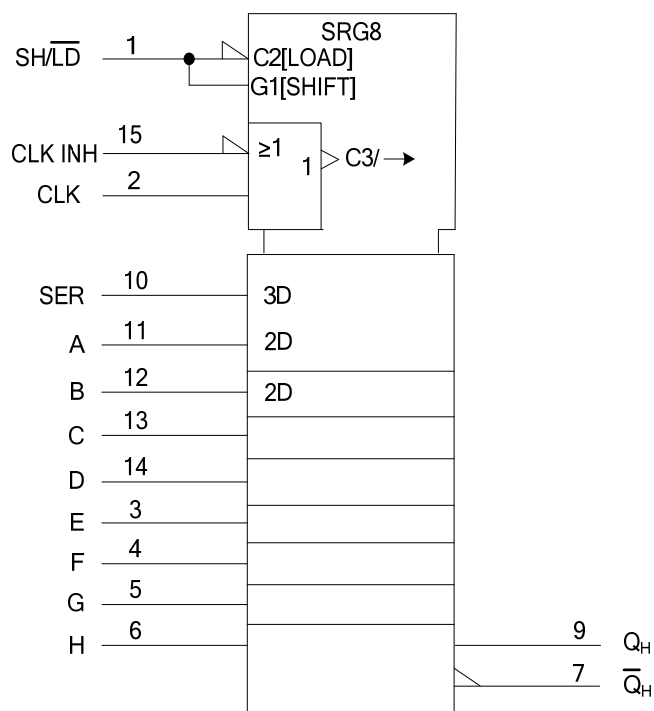
l= LOW Voltage Level one set-up time prior to the LOW-to-HIGH clock transition;

q=state of the referenced output one set-up time prior to the LOW-to-HIGH clock transition;

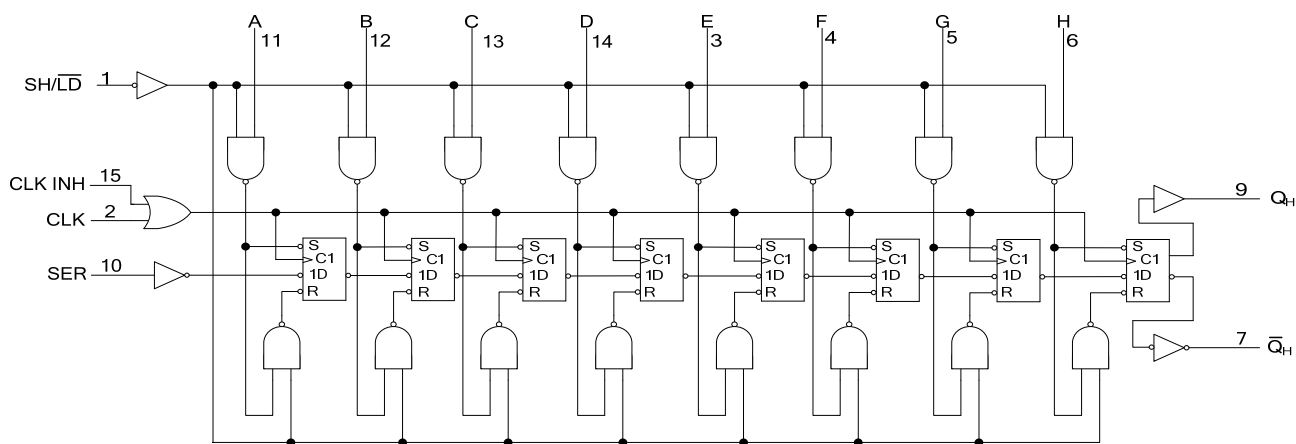
X=don't care;

↑= LOW-to-HIGH clock transition.

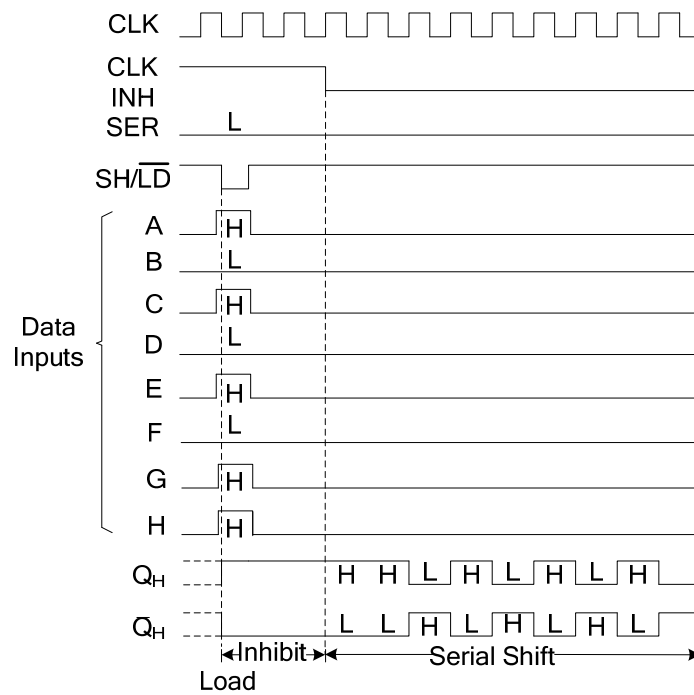
■ LOGIC SYMBOL



■ LOGIC DIAGRAM (positive logic)



■ TYPICAL SHIFT, LOAD, AND INHIBIT SEQUENCE



■ ABSOLUTE MAXIMUM RATING

PARAMETER	SYMBOL	CONDITIONS	RATINGS	UNIT
Supply Voltage	V_{CC}		-0.5 ~ 7	V
V_{CC} or GND Current	I_{CC}		±50	mA
Output Current	I_{OUT}	$V_{OUT} = 0$ to V_{CC}	±25	mA
Input Clamp Current	I_{IK}	$V_{IN} < 0$ or $V_{IN} > V_{CC} + 0.5V$	±20	mA
Output Clamp Current	I_{OK}	$V_{OUT} < 0$ or $V_{OUT} > V_{CC} + 0.5V$	±20	mA
Electrostatic Discharge	$V_{(ESD)}$	Human-Body Model (HBM) Per JESD22-A114/115	2000	V
Storage Temperature	T_{STG}		-65 ~ + 150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
Supply Voltage	V_{CC}		4.5		5.5	V
Input Voltage	V_{IN}		0		V_{CC}	V
Output Voltage	V_{OUT}		0		V_{CC}	V
Input Transition Rise or Fall Time	t_R / t_F	$V_{CC} = 4.5V \sim 5.5V$			500	ns
Operating Free-air Temperature	T_A		-40		+125	°C

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT
Junction to Ambient	θ_{JA}	73	°C/W

■ ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
High-Level Input Voltage	V_{IH}	$V_{CC} = 4.5V \sim 5.5V$	2			V
Low-Level Input Voltage	V_{IL}	$V_{CC} = 4.5V \sim 5.5V$			0.8	V
High-Level Output Voltage	V_{OH}	$V_{CC} = 4.5V, I_{OH} = -20\mu A$	4.4	4.5		V
		$V_{CC} = 4.5V, I_{OH} = -4mA$	3.98	4.28		V
Low-Level Output Voltage	V_{OL}	$V_{CC} = 4.5V, I_{OL} = 20\mu A$		0	0.1	V
		$V_{CC} = 4.5V, I_{OL} = 4mA$		0.15	0.26	V
Input Leakage Current	$I_{I(LEAK)}$	$V_{CC} = 5.5V, V_{IN} = V_{CC}$ or GND			±100	nA
Quiescent Supply Current	I_{CC}	$V_{CC} = 5.5V, V_{IN} = V_{CC}$ or GND			8	μA
Additional supply current	ΔI_{CC}	$V_{IN} = V_{CC} - 2.1V$, other inputs at V_{CC} or GND, $V_{CC} = 4.5V$ to $5.5V$, DS, Dn inputs			126	uA
		$V_{IN} = V_{CC} - 2.1V$, other inputs at V_{CC} or GND, $V_{CC} = 4.5V$ to $5.5V$, CLK, CLKINH, SH/LD inputs			234	uA
Input Capacitance	C_i				10	pF

■ **TIMING REQUIREMENTS** ($T_A = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Clock frequency		f_{CLOCK}	$V_{\text{CC}}=4.5\text{V}$	26			MHz
Pulse duration	CLK high input	t_W	$V_{\text{CC}}=4.5\text{V}$	18			ns
	SH/LD low input		$V_{\text{CC}}=4.5\text{V}$	20			ns
Setup time	DS before CLK, CLK INH	t_{SU}	$V_{\text{CC}}=4.5\text{V}$	20			ns
	CLK INH to CLK, CLK to CLK INH		$V_{\text{CC}}=4.5\text{V}$	20			ns
	Dn to SH/LD		$V_{\text{CC}}=4.5\text{V}$	20			ns
Hold time	DS to CLK, CLK INH	t_{H}	$V_{\text{CC}}=4.5\text{V}$	7			ns
	CLK to CLK INH, CLK INH to CLK		$V_{\text{CC}}=4.5\text{V}$	7			ns

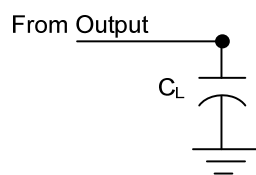
■ **SWITCHING CHARACTERISTICS** ($t_R = t_F = 6\text{ns}$, $C_L = 50\text{pF}$, $T_A = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from SH/ $\overline{\text{LD}}$ to QH or $\overline{\text{Q}}_{\text{H}}$	t_{PD} ($t_{\text{PLH}}/ t_{\text{PHL}}$)	$V_{\text{CC}}=4.5\text{V}$			40	ns
		$V_{\text{CC}}=5\text{V}$, $C_{\text{L}}=15\text{pF}$		17	40	ns
Propagation delay from CLK, CLK, INH to QH or $\overline{\text{Q}}_{\text{H}}$		$V_{\text{CC}}=4.5\text{V}$			40	ns
		$V_{\text{CC}}=5\text{V}$, $C_{\text{L}}=15\text{pF}$		14	40	ns
Propagation delay from D7 to QH or $\overline{\text{Q}}_{\text{H}}$		$V_{\text{CC}}=4.5\text{V}$			35	ns
		$V_{\text{CC}}=5\text{V}$, $C_{\text{L}}=15\text{pF}$		11	35	ns
Transition time	t_{T}	$V_{\text{CC}}=4.5\text{V}$		7	15	ns

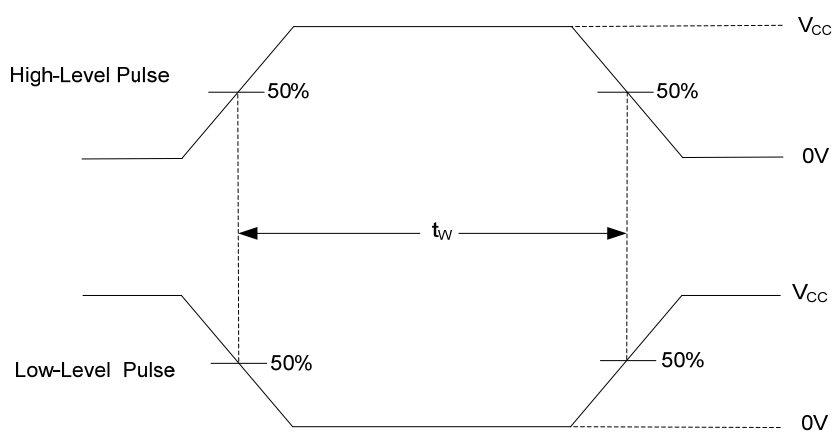
■ **OPERATING CHARACTERISTICS** ($T_A = 25^\circ\text{C}$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Power Dissipation Capacitance	C_{PD}	No load		35		pF

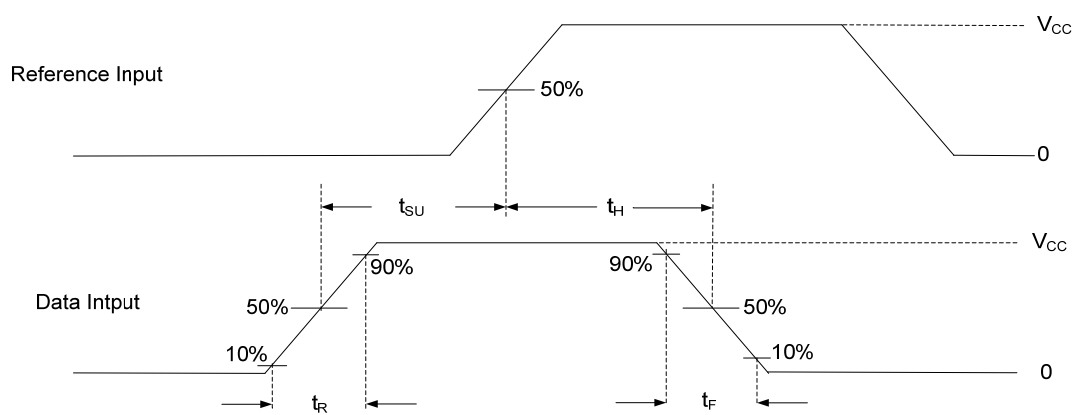
■ TEST CIRCUIT AND WAVEFORMS



TEST CIRCUIT

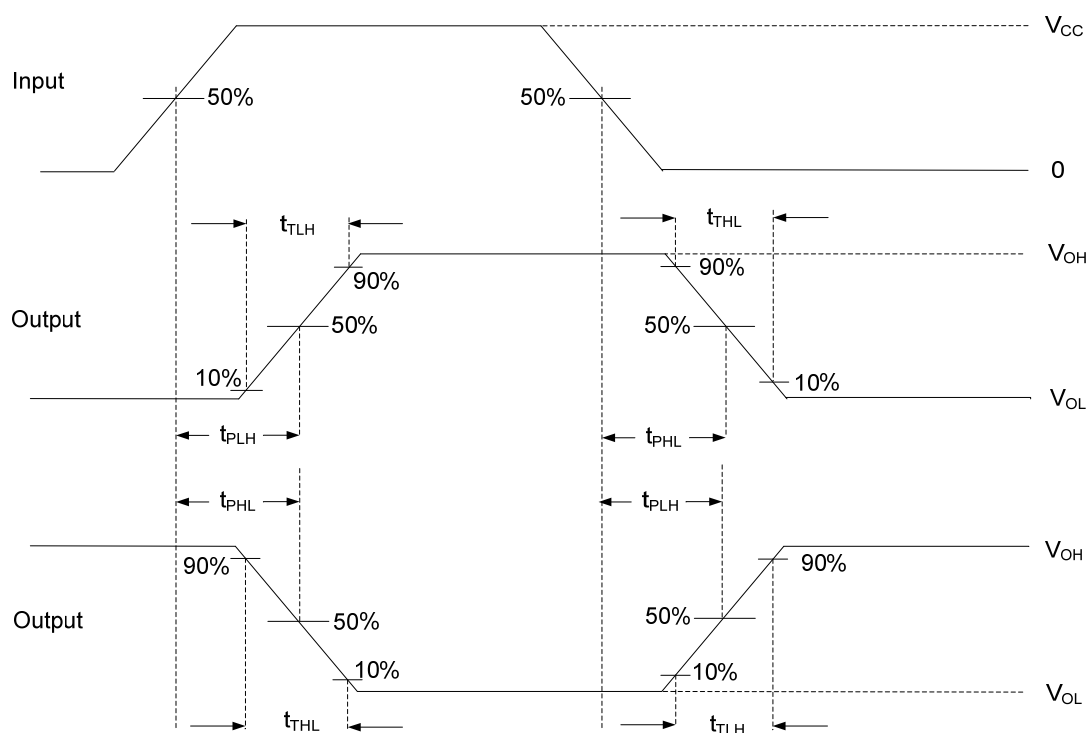


PULSE DURATIONS



SET AND HOLD AND INPUT RISE AND FALL TIMES

■ TEST CIRCUIT AND WAVEFORMS (Cont.)



PROPAGATION DELAY AND OUTPUT TRANSITION TIMES

Note : t_{THL} and t_{TLH} are the same as t_r

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